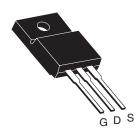


2SK2932-VB Datasheet N-Channel 60 V (D-S) MOSFET

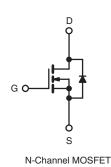
PRODUCT SUMMARY							
V _{DS} (V)	60						
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.027					
Q _g (Max.) (nC)	95						
Q _{gs} (nC)	27						
Q _{gd} (nC)	46						
Configuration	Single						

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- · Lead (Pb)-free Available



TO-220 FULLPAK



ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted SYMBOL PARAMETER LIMIT UNIT 60 **Drain-Source Voltage** V_{DS} v Gate-Source Voltage ± 20 V_{GS} $T_C = 25 \ ^{\circ}C$ 45 V_{GS} at 10 V **Continuous Drain Current** I_D $T_C = 100 \degree C$ А 30 Pulsed Drain Currenta I_{DM} 220 Linear Derating Factor 0.32 W/°C Single Pulse Avalanche Energy^b E_{AS} 100 mJ T_C = 25 °C Maximum Power Dissipation 52 W P_D Peak Diode Recovery dV/dtc dV/dt V/ns 4.5 Operating Junction and Storage Temperature Range T_J, T_{stg} - 55 to + 175 °C Soldering Recommendations (Peak Temperature) for 10 s 300^d 10 lbf · in Mounting Torque 6-32 or M3 screw N·m 1.1

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 129 μ H, $R_G = 25 \Omega$, $I_{AS} = 30 \text{ A}$ (see fig. 12). c. $I_{SD} \le 52 \text{ A}$, dI/dt $\le 250 \text{ A}/\mu$ s, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.

Г

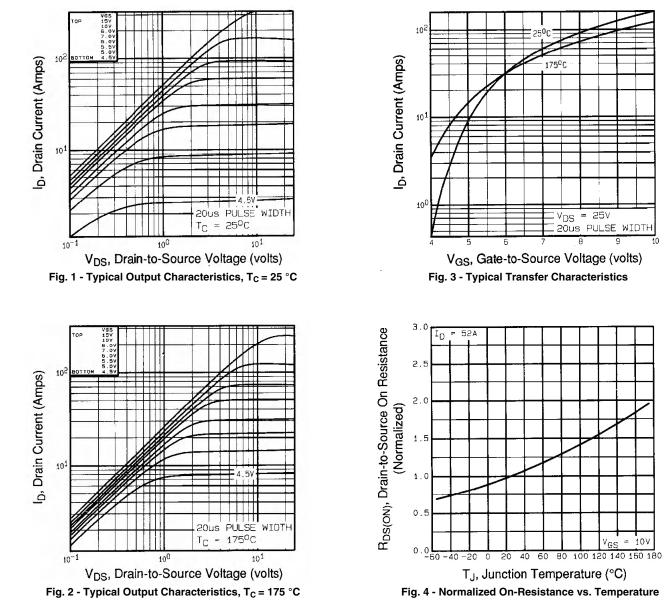


THERMAL RESISTANCE RAT	TINGS								
PARAMETER	SYMBOL	TYP	•	MAX.			UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 65			*C1W				
Maximum Junction-to-Case (Drain)	R _{thJC}	-		3.1	°C/W				
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted			1		1		
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V_{GS} = 0 V, I_D = 250 μ A			60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, $I_D = 1 \text{ mA}$			-	0.060	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			1.0	-	3.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V			-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	μA	
		$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$			-	-	250		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V I _D = 18 A ^b			-	0.027	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS} = 25 V, I _D = 18 A ^b			15	-	-	S	
Dynamic									
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5			-	1500	-		
Output Capacitance	C _{oss}			-	720	-	рF		
Reverse Transfer Capacitance	C _{rss}			-	100	-			
Drain to Sink Capacitance	С	f = 1.0 MHz			-	12		-	
Total Gate Charge	Qg				-	-	95		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 52 \text{ A}, V_{DS} = 2 \text{ see fig. 6 and 1}$		-	-	27	nC	
Gate-Drain Charge	Q _{gd}				-	-	46		
Turn-On Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 52 A, R _G = 9.1 Ω, R _D = 0.54 Ω, see fig. 10 ^b			-	19	-	1	
Rise Time	tr			-	120	-	- ns		
Turn-Off Delay Time	t _{d(off)}			-	55	-			
Fall Time	t _f			-	86	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact			-	4.5	-	nH	
Internal Source Inductance	L _S				-	7.5	-		
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode			-	-	45	A	
Pulsed Diode Forward Current ^a	I _{SM}				-	-	120		
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 30 \ A, \ V_{GS} = 0 \ V^b$			-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^\circ C$, $I_F = 52 \ A$, $dl/dt = 100 \ A/\mu s^b$			-	140	300	ns	
Body Diode Reverse Recovery Charge	Q _{rr}				-	1.2	2.8	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)							

Notes

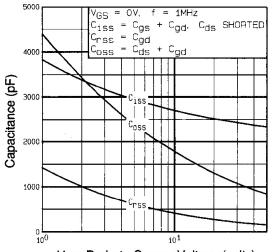
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





V_{DS}, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

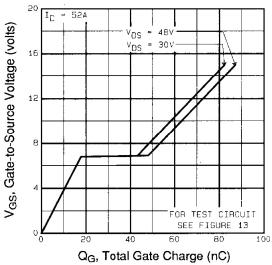


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

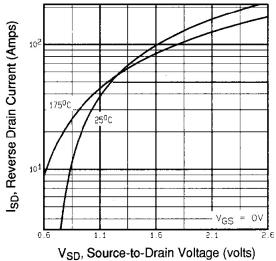
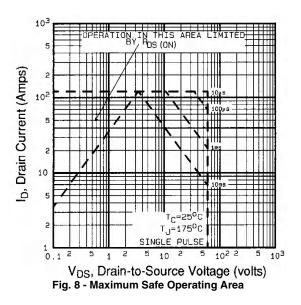


Fig. 7 - Typical Source-Drain Diode Forward Voltage



2SK2932-VB



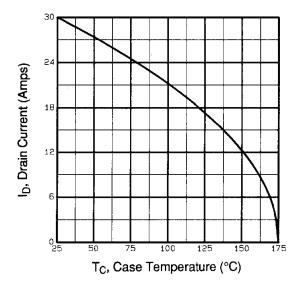


Fig. 9 - Maximum Drain Current vs. Case Temperature

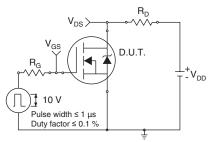


Fig. 10a - Switching Time Test Circuit

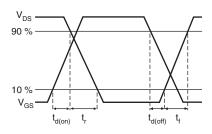


Fig. 10b - Switching Time Waveforms

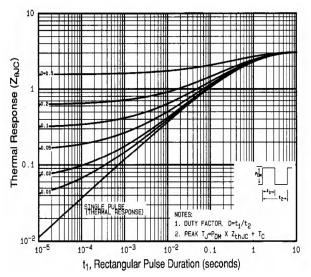
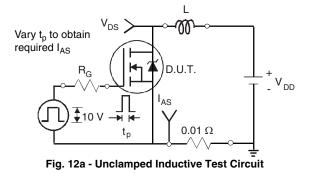


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



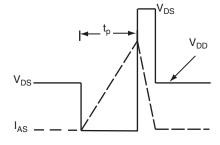
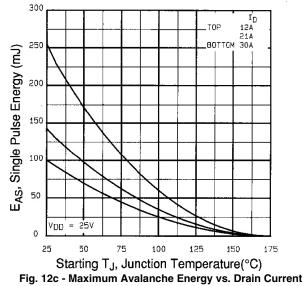
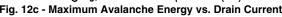


Fig. 12b - Unclamped Inductive Waveforms







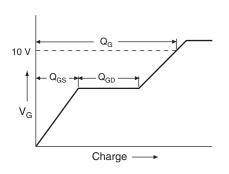
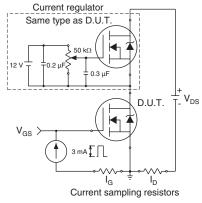
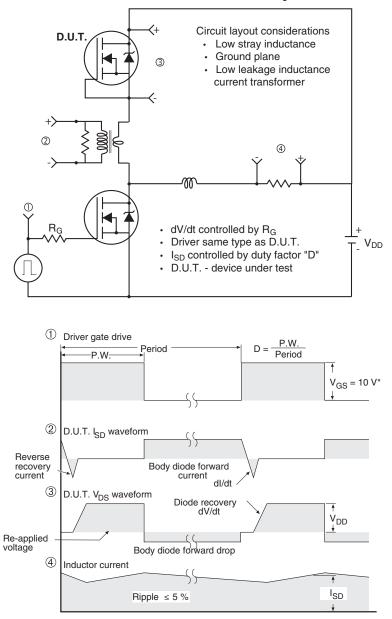


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel



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